

# EVVOSEMI<sup>®</sup>

THINK CHANGE DO



ESD



TVS



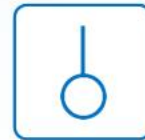
MOS



LDO



Diode



Sensor



DC-DC

## Product Specification

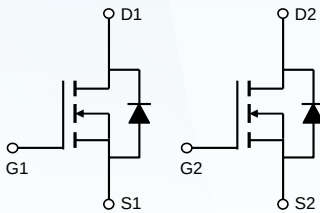
|              |             |        |
|--------------|-------------|--------|
| ▶ Domestic   | Part Number | AO6802 |
| ▶ Overseas   | Part Number | AO6802 |
| ▶ Equivalent | Part Number | AO6802 |

EV is the abbreviation of name EVVO

Dual N Channel MOSFET

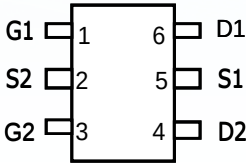
General Description

The AO6802 uses advanced trench technology to provide excellent  $R_{DS(ON)}$  and low gate charge. This device is suitable for use as a load switch or in PWM applications.



Product Summary

- $V_{DS}$  (V)= 30V
- $R_{DS(ON)} < 50m\Omega$  ( $V_{GS} = 10V$ )
- $R_{DS(ON)} < 70 m\Omega$  ( $V_{GS} = 4.5V$ )



SOT23-6

Absolute Maximum Ratings  $T_A=25^{\circ}C$  unless otherwise noted

| Parameter                              | Symbol         | Maximum    | Units       |
|----------------------------------------|----------------|------------|-------------|
| Drain-Source Voltage                   | $V_{DS}$       | 30         | V           |
| Gate-Source Voltage                    | $V_{GS}$       | $\pm 20$   | V           |
| Continuous Drain Current               | $I_D$          | 3.5        | A           |
|                                        |                | 3          |             |
| Pulsed Drain Current <sup>C</sup>      | $I_{DM}$       | 20         |             |
| Power Dissipation <sup>B</sup>         | $P_D$          | 1.15       | W           |
|                                        |                | 0.73       |             |
| Junction and Storage Temperature Range | $T_J, T_{STG}$ | -55 to 150 | $^{\circ}C$ |

| Thermal Characteristics                    |              |                 |     |     |               |
|--------------------------------------------|--------------|-----------------|-----|-----|---------------|
| Parameter                                  |              | Symbol          | Typ | Max | Units         |
| Maximum Junction-to-Ambient <sup>A</sup>   | $t \leq 10s$ | $R_{\theta JA}$ | 78  | 110 | $^{\circ}C/W$ |
| Maximum Junction-to-Ambient <sup>A D</sup> | Steady-State |                 | 106 | 150 | $^{\circ}C/W$ |
| Maximum Junction-to-Lead                   | Steady-State | $R_{\theta JL}$ | 64  | 80  | $^{\circ}C/W$ |

## Dual N Channel MOSFET

Electrical Characteristics ( $T_J=25^{\circ}\text{C}$  unless otherwise noted)

| Symbol                      | Parameter                             | Conditions                                                                         | Min | Typ  | Max       | Units            |
|-----------------------------|---------------------------------------|------------------------------------------------------------------------------------|-----|------|-----------|------------------|
| <b>STATIC PARAMETERS</b>    |                                       |                                                                                    |     |      |           |                  |
| $BV_{DSS}$                  | Drain-Source Breakdown Voltage        | $I_D=250\mu\text{A}$ , $V_{GS}=0\text{V}$                                          | 30  |      |           | V                |
| $I_{DSS}$                   | Zero Gate Voltage Drain Current       | $V_{DS}=30\text{V}$ , $V_{GS}=0\text{V}$                                           |     |      | 1         | $\mu\text{A}$    |
| $I_{GSS}$                   | Gate-Body leakage current             | $V_{DS}=0\text{V}$ , $V_{GS}=\pm 20\text{V}$                                       |     |      | $\pm 100$ | nA               |
| $V_{GS(th)}$                | Gate Threshold Voltage                | $V_{DS}=V_{GS}$ , $I_D=250\mu\text{A}$                                             | 1.5 | 2    | 2.5       | V                |
| $I_{D(ON)}$                 | On state drain current                | $V_{GS}=10\text{V}$ , $V_{DS}=5\text{V}$                                           | 20  |      |           | A                |
| $R_{DS(ON)}$                | Static Drain-Source On-Resistance     | $V_{GS}=10\text{V}$ , $I_D=3.5\text{A}$                                            |     | 40   | 50        | $\text{m}\Omega$ |
|                             |                                       | $V_{GS}=4.5\text{V}$ , $I_D=2\text{A}$                                             |     | 52   | 70        | $\text{m}\Omega$ |
| $g_{FS}$                    | Forward Transconductance              | $V_{DS}=5\text{V}$ , $I_D=3.5\text{A}$                                             |     | 12   |           | S                |
| $V_{SD}$                    | Diode Forward Voltage                 | $I_S=1\text{A}$ , $V_{GS}=0\text{V}$                                               |     | 0.79 | 1         | V                |
| $I_S$                       | Maximum Body-Diode Continuous Current |                                                                                    |     |      | 1.5       | A                |
| <b>DYNAMIC PARAMETERS</b>   |                                       |                                                                                    |     |      |           |                  |
| $C_{iss}$                   | Input Capacitance                     | $V_{GS}=0\text{V}$ , $V_{DS}=15\text{V}$ , $f=1\text{MHz}$                         |     | 170  | 210       | pF               |
| $C_{oss}$                   | Output Capacitance                    |                                                                                    |     | 35   |           | pF               |
| $C_{rss}$                   | Reverse Transfer Capacitance          |                                                                                    |     | 23   |           | pF               |
| $R_g$                       | Gate resistance                       | $V_{GS}=0\text{V}$ , $V_{DS}=0\text{V}$ , $f=1\text{MHz}$                          | 1.7 | 3.5  | 5.3       | $\Omega$         |
| <b>SWITCHING PARAMETERS</b> |                                       |                                                                                    |     |      |           |                  |
| $Q_g(10\text{V})$           | Total Gate Charge                     | $V_{GS}=10\text{V}$ , $V_{DS}=15\text{V}$ , $I_D=3.5\text{A}$                      |     | 4.05 | 5         | nC               |
| $Q_g(4.5\text{V})$          | Total Gate Charge                     |                                                                                    |     | 2    | 3         | nC               |
| $Q_{gs}$                    | Gate Source Charge                    |                                                                                    |     | 0.55 |           | nC               |
| $Q_{gd}$                    | Gate Drain Charge                     |                                                                                    |     | 1    |           | nC               |
| $t_{D(on)}$                 | Turn-On DelayTime                     | $V_{GS}=10\text{V}$ , $V_{DS}=15\text{V}$ , $R_L=4.2\Omega$ ,<br>$R_{GEN}=3\Omega$ |     | 4.5  |           | ns               |
| $t_r$                       | Turn-On Rise Time                     |                                                                                    |     | 1.5  |           | ns               |
| $t_{D(off)}$                | Turn-Off DelayTime                    |                                                                                    |     | 18.5 |           | ns               |
| $t_f$                       | Turn-Off Fall Time                    |                                                                                    |     | 15.5 |           | ns               |
| $t_{rr}$                    | Body Diode Reverse Recovery Time      | $I_F=3.5\text{A}$ , $dI/dt=100\text{A}/\mu\text{s}$                                |     | 7.5  | 10        | ns               |
| $Q_{rr}$                    | Body Diode Reverse Recovery Charge    | $I_F=3.5\text{A}$ , $dI/dt=100\text{A}/\mu\text{s}$                                |     | 2.5  |           | nC               |

A. The value of  $R_{\theta JA}$  is measured with the device mounted on  $1\text{in}^2$  FR-4 board with 2oz. Copper, in a still air environment with  $T_A=25^{\circ}\text{C}$ . The value in any given application depends on the user's specific board design.

B. The power dissipation  $P_D$  is based on  $T_{J(MAX)}=150^{\circ}\text{C}$ , using  $\leq 10\text{s}$  junction-to-ambient thermal resistance.

C. Repetitive rating, pulse width limited by junction temperature  $T_{J(MAX)}=150^{\circ}\text{C}$ . Ratings are based on low frequency and duty cycles to keep initial  $T_J=25^{\circ}\text{C}$ .

D. The  $R_{\theta JA}$  is the sum of the thermal impedance from junction to lead  $R_{\theta JL}$  and lead to ambient.

E. The static characteristics in Figures 1 to 6 are obtained using  $<300\mu\text{s}$  pulses, duty cycle 0.5% max.

F. These curves are based on the junction-to-ambient thermal impedance which is measured with the device mounted on  $1\text{in}^2$  FR-4 board with 2oz. Copper, assuming a maximum junction temperature of  $T_{J(MAX)}=150^{\circ}\text{C}$ . The SOA curve provides a single pulse rating.

## Dual N Channel MOSFET

## N-Channel: TYPICAL ELECTRICAL AND THERMAL CHARACTERISTICS

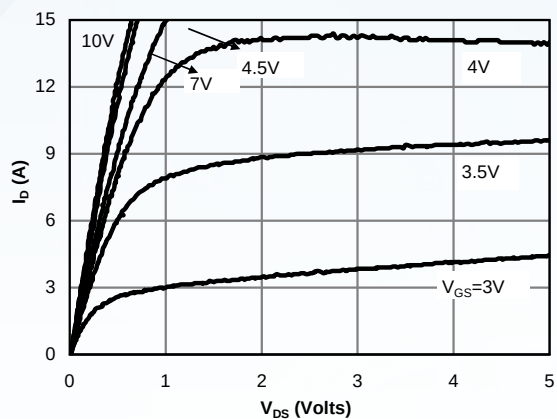


Fig 1: On-Region Characteristics (Note E)

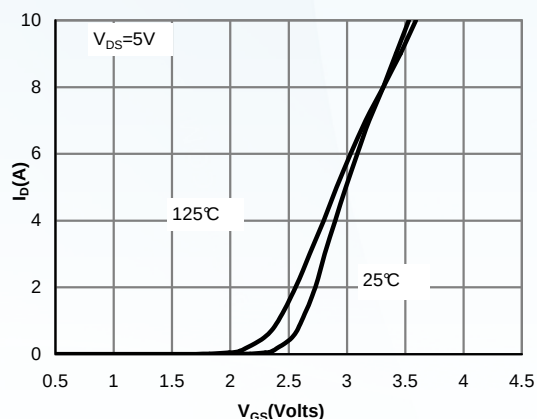


Figure 2: Transfer Characteristics (Note E)

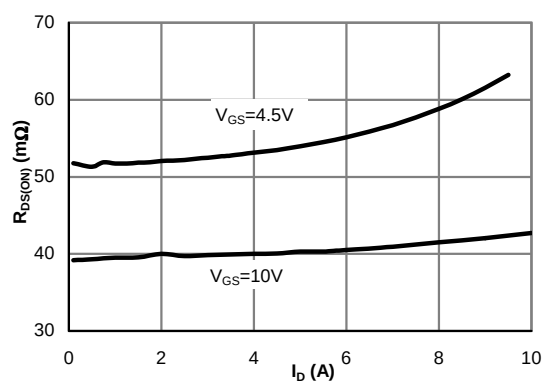


Figure 3: On-Resistance vs. Drain Current and Gate Voltage (Note E)

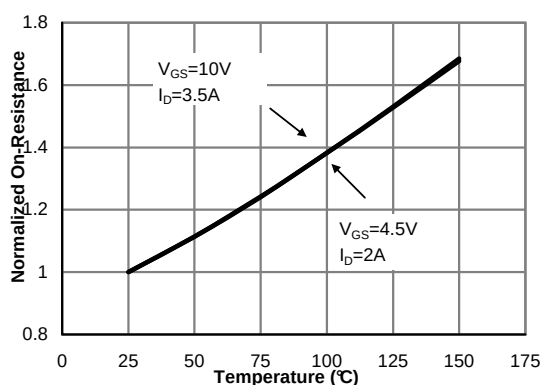


Figure 4: On-Resistance vs. Junction Temperature (Note E)

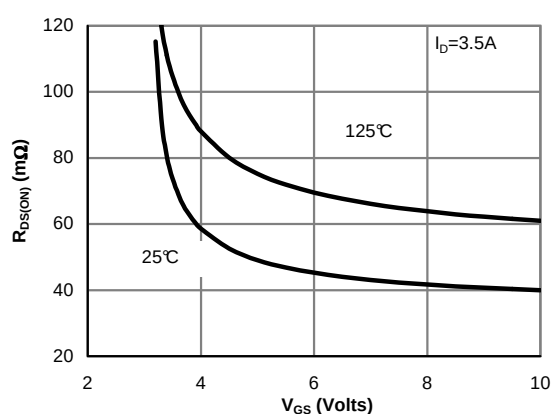


Figure 5: On-Resistance vs. Gate-Source Voltage (Note E)

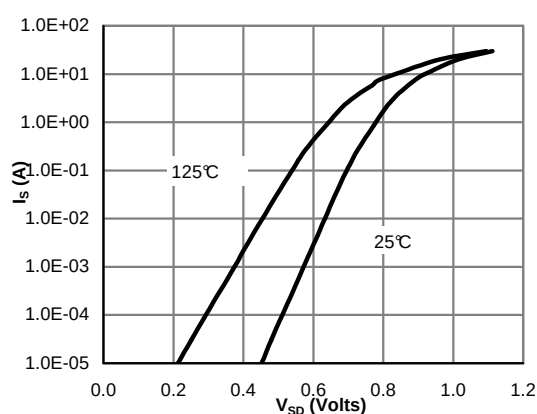
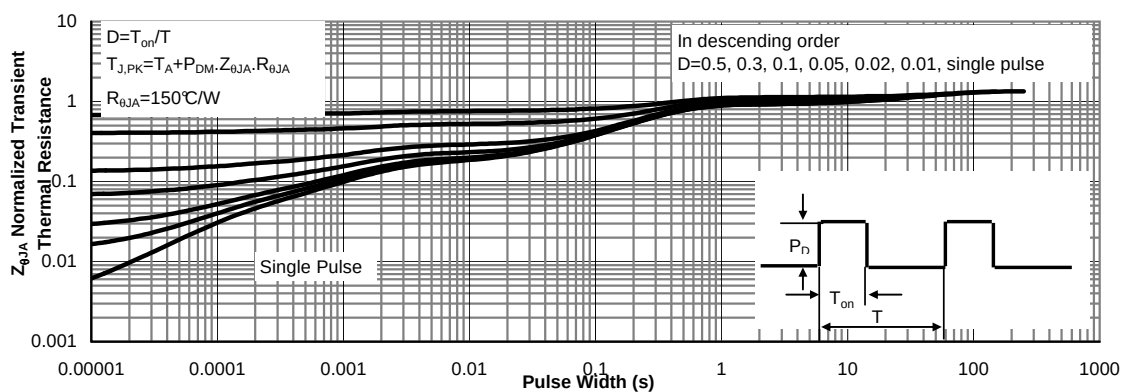
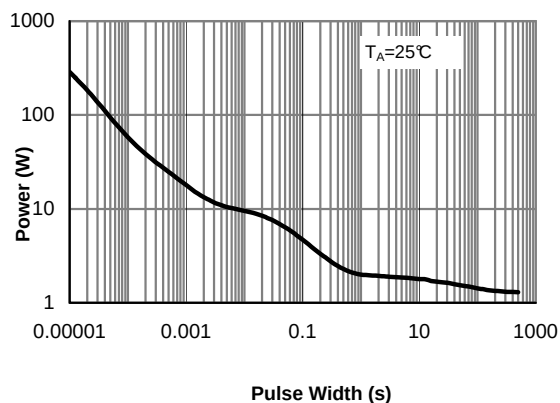
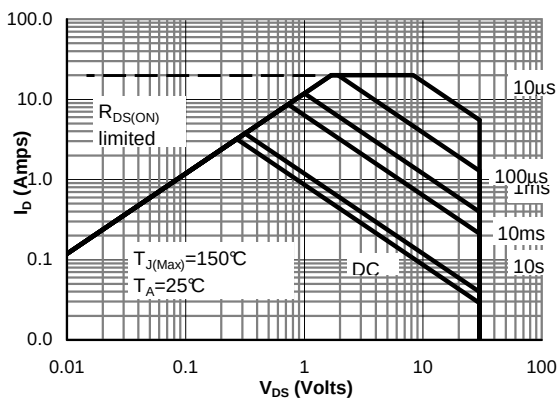
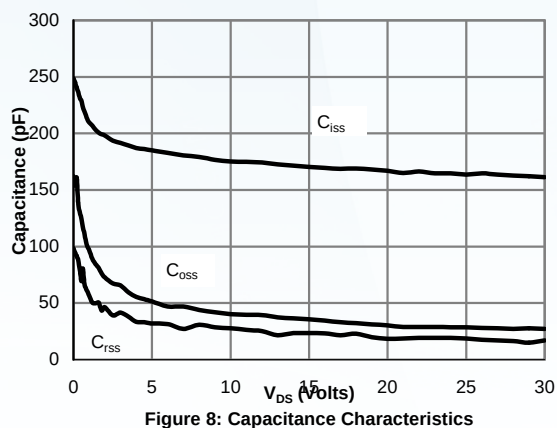
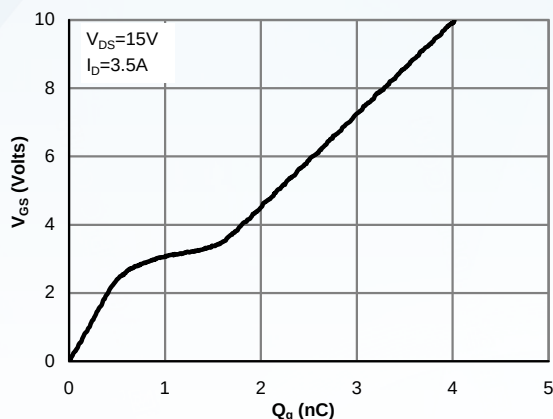


Figure 6: Body-Diode Characteristics (Note E)

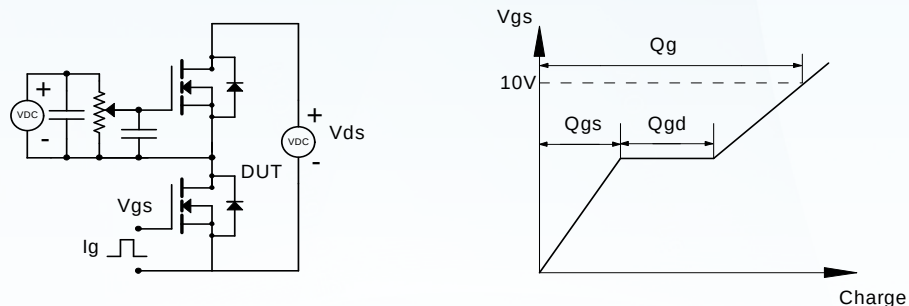
## Dual N Channel MOSFET

## N-Channel: TYPICAL ELECTRICAL AND THERMAL CHARACTERISTICS

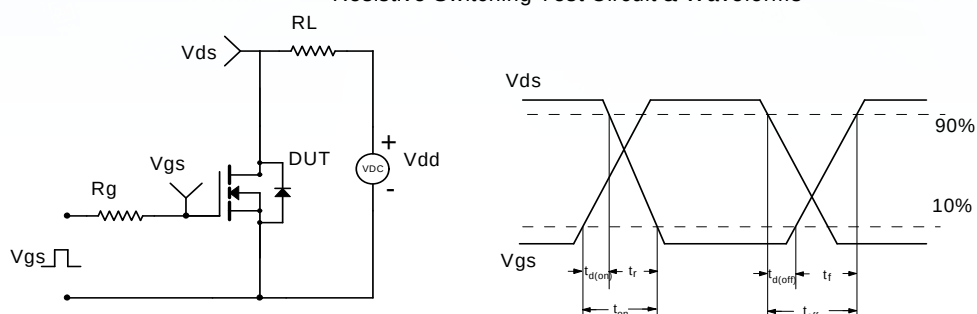


## Dual N Channel MOSFET

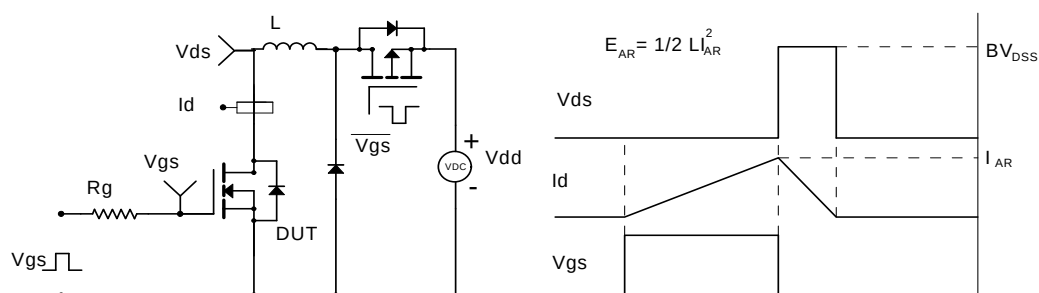
Gate Charge Test Circuit &amp; Waveform



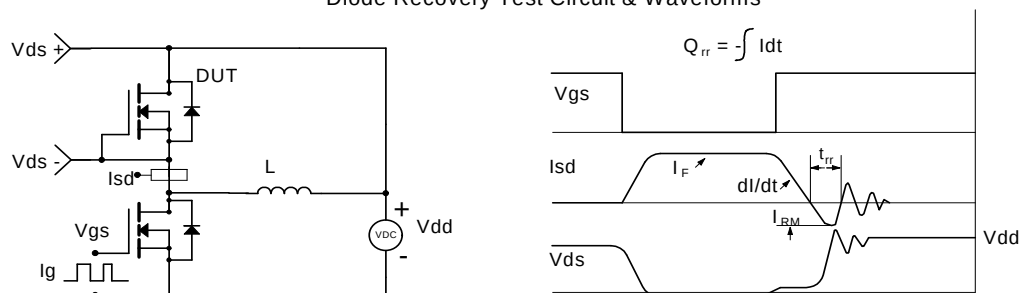
Resistive Switching Test Circuit &amp; Waveforms



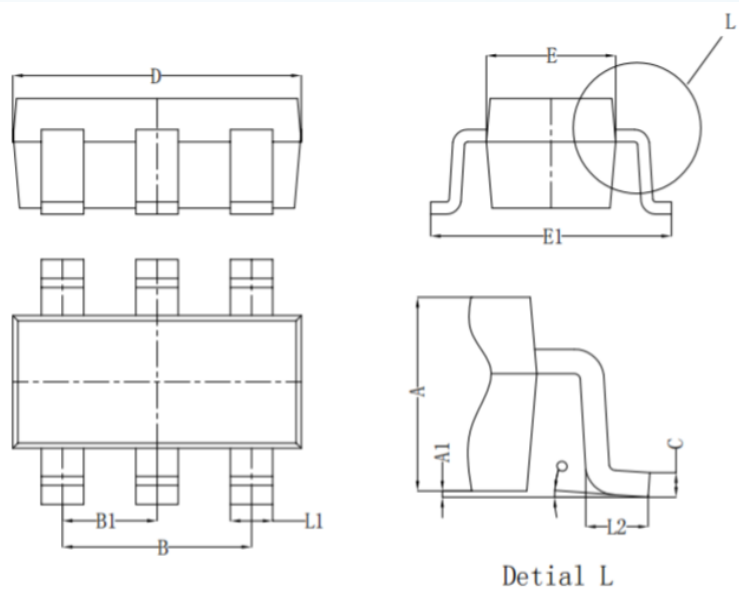
Unclamped Inductive Switching (UIS) Test Circuit &amp; Waveforms



Diode Recovery Test Circuit &amp; Waveforms



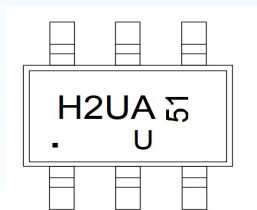
SOT23-6 PACKAGE OUTLIE DIMENSIONS



| Symbol | Dim in mm |       |       |
|--------|-----------|-------|-------|
|        | Min       | Nor   | Max   |
| A      | 1.050     | 1.100 | 1.150 |
| A1     | 0.000     | 0.050 | 0.100 |
| L1     | 0.300     | 0.400 | 0.500 |
| C      | 0.100     | 0.150 | 0.200 |
| D      | 2.820     | 2.920 | 3.020 |
| E      | 1.500     | 1.600 | 1.700 |
| E1     | 2.650     | 2.800 | 2.950 |
| B      | 1.800     | 1.900 | 2.000 |
| B1     | 0.950 TYP |       |       |
| L2     | 0.300     | 0.450 | 0.600 |
| o      | 0°        | 4°    | 8°    |

Dual N Channel MOSFET

## Marking



## Ordering information

| Order code | Package | Baseqty | Deliverymode  |
|------------|---------|---------|---------------|
| AO6802     | SOT23-6 | 3000    | Tape and reel |



## Disclaimer

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